MT8211N3

Dual N-Channel Enhancement Mode Field Effect Transistor

PRODUCT SUMMARY					
VDSS	ID	RDS(ON) (mΩ) Typ			
20V	8A	14 @ VGS=4.5V			
		17 @ VGS=2.5V			
		25 @ VGS=1.8 V			

Features

- · Super high dense cell design for low RDS(ON).
- · Rugged and reliable.
- · Suface Mount Package.
- · ESD Protected.

General Description

This Dual N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Applications

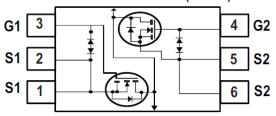
- DC-DC DIVER
- · Bank of Power



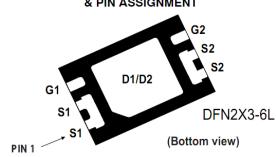
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Simplified Schematic

Bottom Drain Contact (D1/D2)



MARKING DIAGRAM & PIN ASSIGNMENT



ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Symbol	Parameter	Limit	Units	
V_{DS}	Drain-Source Voltage		20	V
V_{GS}	Gate-Source Voltage		±12	V
I _D	Drain Current-Continuous ^c	T _A =25°C	8	А
		T _A =70°C	6.4	А
I _{DM}	-Pulsed ac		48	А
P_D	Maximum Power Dissipation	T _A =25°C	1.56	W
		T _A =70°C	1.00	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range		-55 to 150	°C

THERMAL CHARACTERISTICS

R _{0 JA}	Thermal Resistance, Junction-to-Ambient	80	°C/W

ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CH	ARACTERISTICS					
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , ID=250uA	20			V
IDSS	Zero Gate Voltage Drain Current	Vps=16V, Vgs=0V			1	uA
Igss	Gate-Body Leakage Current	V _{GS} = ±8V , V _{DS} =0V			±1	uA
ON CHA	RACTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	0.45	0.6	1	V
Г	Drain-Source On-State Resistance	Vgs=4.5V , lp=7.0A		14.0	16.0	m ohm
Rds(on)	Diani-Source On-State Resistance	Vgs=2.5V, ID=5.5A		17.0	19.0	m ohm
		Vgs=1.8V , ID=5.0A		25.0	30.0	m ohm
~						
g _{FS}	Forward Transconductance	V _{DS} =5V , I _D =4A		35		S
DYNAMI	C CHARACTERISTICS b					
Ciss	Input Capacitance	\/10\/\/0\/		705		pF
Coss	Output Capacitance	V _{DS} =10V,V _{GS} =0V f=1.0MHz		235		pF
Crss	Reverse Transfer Capacitance	T=1.0IVIDZ		218		pF
SWITCH	ING CHARACTERISTICS b					
td(ON)	Turn-On Delay Time	V _{DD} =10V		25		ns
tr	Rise Time	I _D =1A		89		ns
tD(OFF)	Turn-Off Delay Time	Vgs=4.5V		110		ns
tf	Fall Time	RGEN=6 ohm		102		ns
Qg	Total Gate Charge	Vps=10V,lp=4A,Vgs=4.5V		13.4		nC
		Vps=10V,lp=4A,Vgs=2.5V		10.2		nC
Qgs	Gate-Source Charge	V _{DS} =10V,I _D =4A,		2		nC
Qgd	Gate-Drain Charge	V _{GS} =4.5V		6		nC
DRAIN-S	OURCE DIODE CHARACTERISTIC	S AND MAXIMUM RATINGS	 }			
VsD	Diode Forward Voltage	Vgs=0V,ls=1A		0.75		V
	<u> </u>					

Notes

- a.Pulse Test:Pulse Width ≤ 10us, Duty Cycle ≤ 1%.
- b.Guaranteed by design, not subject to production testing.
- c.Drain current limited by maximum junction temperature. d.Mounted on FR4 Board of 1 inch², 2oz.

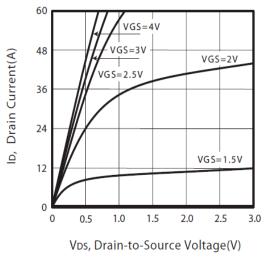


Figure 1. Output Characteristics

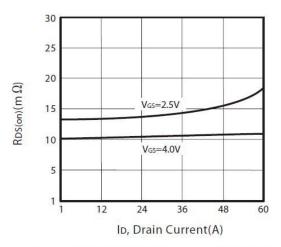


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

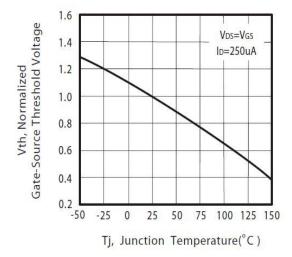


Figure 5. Gate Threshold Variation with Temperature

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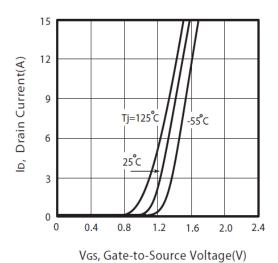


Figure 2. Transfer Characteristics

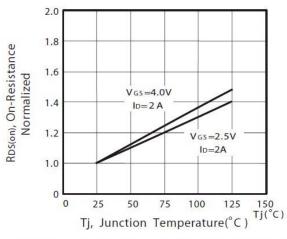


Figure 4. On-Resistance Variation with Drain Current and Temperature

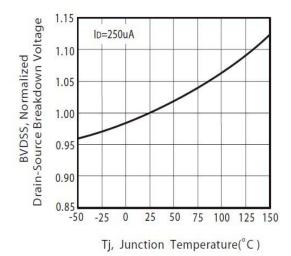


Figure 6. Breakdown Voltage Variation with Temperature

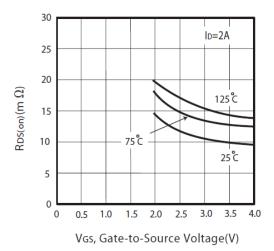


Figure 7. On-Resistance vs. Gate-Source Voltage

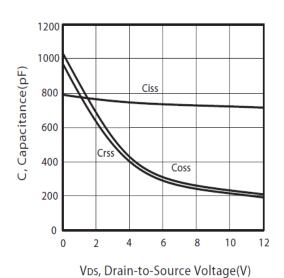


Figure 9. Capacitance

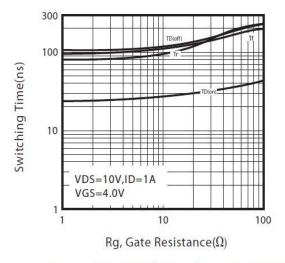
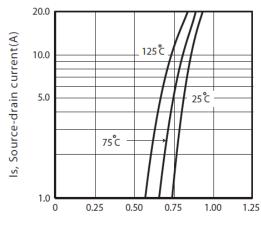


Figure 11. switching characteristics



Vsp, Body Diode Forward Voltage(V)

Figure 8. Body Diode Forward Voltage Variation with Source Current

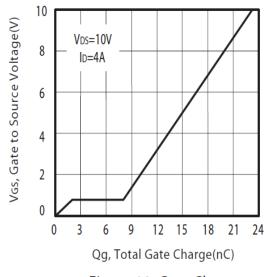


Figure 10. Gate Charge

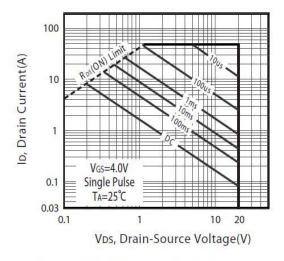
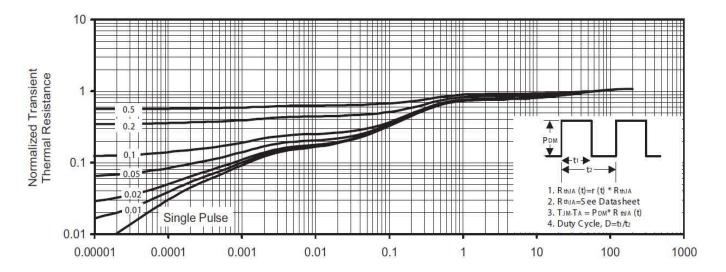


Figure 12. Maximum Safe Operating Area

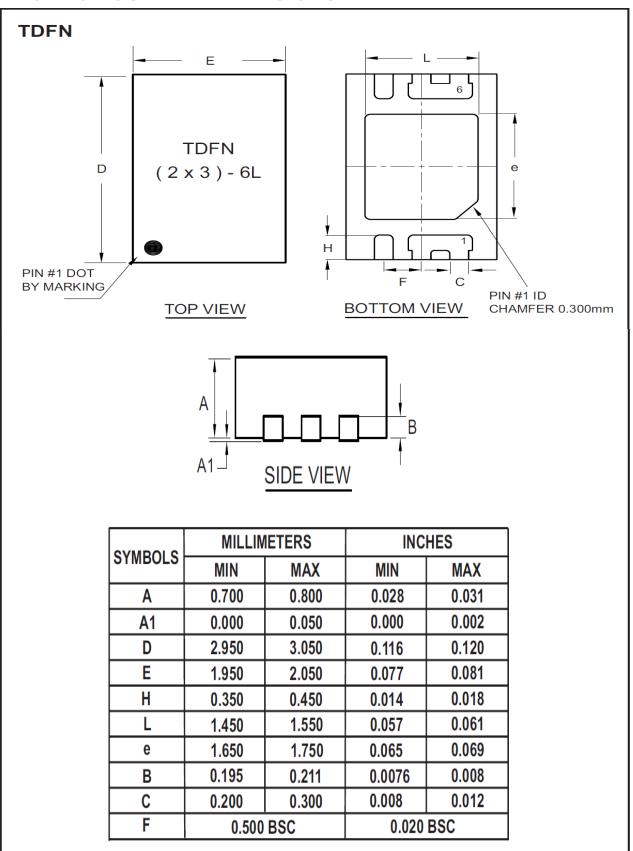
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Square Wave Pulse Duration(sec)
Normalized Thermal Transient Impedance Curve

PACKAGE OUTLINE DIMENSIONS



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